ALUMINUM ELECTROLYTIC CAPACITORS



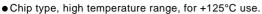
Chip Type, High Reliability. Low temperature ESR specification.











- Added ESR specification after the test at -40°C (\(\phi 6.3 \) sizes provide only for the first stage.)
- Applicable to automatic mounting machine using carrier tape.
- Adapted to the RoHS directive (2002/95/EC).

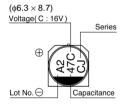


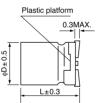
Specifications

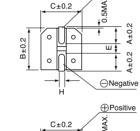
Specifications													
Item	Performance Characteristics												
Category Temperature Range	-40 ~ +125°C												
Rated Voltage Range	10 ~ 50V												
Rated Capacitance Range	10 ~ 470μF												
Capacitance Tolerance	±20% at 120Hz, 20°C												
Leakage Current	After 1 minute's application of rated voltage, leakage current is not more than 0.03CV or 4(µA), whichever is greater.												
	Measurement frequency : 120Hz, Temperature : 20°C												
tan δ	Rated voltage (V) 10 16 25 35 50												
	tan δ (MAX.) 0.32 0.24 0.21 0.18 0.18												
	Measurement frequency : 120Hz												
Stability at Low Temperature	Rated voltage (V) 10 16 25 35 50												
	Impedance ratio Z-40°C / Z+20°C 12 8 6 4 4												
Endurance	After 2000 hours' application of rated voltage at 125°C, capacitors meet the characteristic requirements listed at right. Capacitance change within ±30% of initial value tan δ 300% or less of initial specified value Leakage current Initial specified value or less												
Shelf Life	After storing the capacitors under no load at 125°C for 1000 hours, and after performing voltage treatment based on JIS C 5101-4 clause 4.1 at 20°C, they will meet the specified value for endurance characteristics listed above.												
Resistance to soldering heat	The capacitors shall be kept on the hot plate maintained at 250 °C for 30 seconds. After removing from the hot plate and restored at room temperature, they meet the characteristic requirements listed at right. Capacitance change Within $\pm 10\%$ of initial value $\tan \delta$ Initial specified value or less Leakage current Initial specified value or less												
Marking	Black print on the case top.												

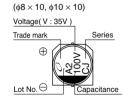
⊕Positive

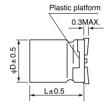
■Chip Type

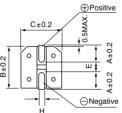




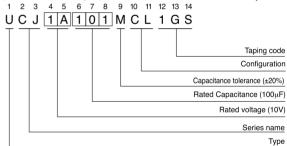








Type numbering system (Example : 10V $100\mu F$)



6.3 × 8.7	8 × 10	10 × 10
2.4	2.9	3.2
6.6	8.3	10.3
6.6	8.3	10.3
2.2	3.1	4.5
8.7	10	10
0.5 ~ 0.8	0.8 ~ 1.1	0.8 ~ 1.1
	2.4 6.6 6.6 2.2 8.7	2.4 2.9 6.6 8.3 6.6 8.3 2.2 3.1

Dimensions

	V	/ 10			16			25			35				50						
Cap.(µF)	Code		1A				1C				1E				1V				1H		
10	100							i						6.3×8.7	14	-	95	6.3×8.7	14	-	95
22	220			į				i		6.3×8.7	14	-	95	6.3×8.7	14	-	95	6.3×8.7	14	-	95
33	330									6.3×8.7	14	-	95	6.3×8.7	14	-	95	8×10	2.0	6.0	200
47	470			ļ		6.3×8.7	14	-	95	6.3×8.7	14	-	95	6.3×8.7	14	-	95	10×10	1.5	4.5	330
100	101	6.3×8.7	14	-	95	8×10	2.0	6.0	250	8×10	2.0	6.0	250	10×10	1.5	4.5	400	10×10	1.5	4.5	330
220	221	8×10	2.0	6.0	250	10×10	1.5	4.5	400	10×10	1.5	4.5	400	10×10	1.5	4.5	400	Case size	 Initial	after	Datad
330	331	10×10	1.5	4.5	400	10×10	1.5	4.5	400	10×10	1.5	4.5	400					φD×L	i muai		ripple
470	471	10×10	1.5	4.5	400													(mm)	ES	SR	

Max. ESR (Ω) at -40°C 100kHz, Rated Ripple (mArms) at 125°C 100kHz

Frequency coefficient of rated ripple current

Frequency	50 Hz	120 Hz	300 Hz	1 kHz	10 kHz~
Coefficient	0.35	0.50	0.64	0.83	1.00

- Taping specifications are given in page 24.
- Recommended land size, soldering by reflow are given in page 25, 26.
- Please refer to page 3 for the minimum order quantity.